Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/757,405	TAKINOSAWA ET AL.	
Examiner	Art Unit	
David E. Martinez	2181	

SEARCHED							
Class	Subclass	Date	Examiner				
·							

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
	1		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East see attached	7/25/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	7/25/2006	DM
710/2,62,72,100,300,301,305,313.ccls .with keywords and text search	7/25/2006	DM
,		
	:	